

#### Experiment 1.1.

We will examine forward active mode of BJT transistor in this experiment. In case of  $V_{\text{BE}} > 0$  and

 $V_{BC} < 0$ , collector current will be;

$$I_C \cong I_S e^{V_{BE}/V_T}$$
  
 $I_C = \beta_F I_B$ 

In order to obtain these 2 characteristics, set up the common emitter configuration in Figure 1.  $V_C$  will be 5V and  $R_3$  will be short circuit. BJT transistor is BC238 and the model file of this transistor is at end of the Experiment 1.2. Fill the Table 1 by changing  $R_1$  value. Sweep  $R_1$  from 1k ohm to 1M ohm.

Different  $I_B$  and/or  $V_{BE}$  values can be obtained by changing  $R_1$  resistance in the circuit. Write your measurement result to Table 1. Then draw the graphics in Figure 2 which shows us relationship between  $I_C - V_{BE}$  and  $I_C - I_B$ . You can draw graphs by using Excel.

Note: You can change resistor value in LTspice so you can use resistor instead of potentiometer.

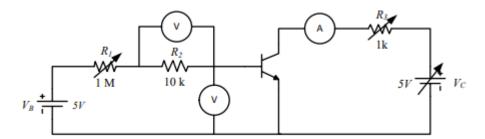


Figure 1: Common emitter configuration



#### Table 1: Measurement results of experiment 1.1

R <sub>1</sub>	V <sub>BE</sub>	Ic	$V_{R2}$	l <sub>Β</sub>	β

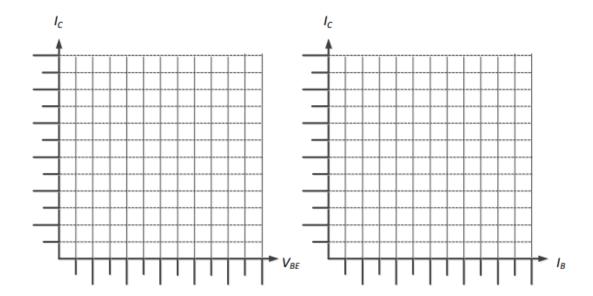


Figure 2:  $I_{C}-V_{BE}$  and  $I_{C}-I_{B}$  graphs



#### Experiment 1.2.

In this experiment we will examine the comparison between different operating modes of BJT transistor. For forward active mode you can choose an average value from  $R_1$  values from Table 1 and write measurement results for this  $R_1$  to Table 2.

For reverse active mode, switch connections between collector and emitter nodes and repeat measurements.

For saturation mode, make  $R_1$  short circuit and connect  $R_3$  as 1k ohm. Thus the transistor will enter saturation point ( $V_{CB} < 0$ ). Write your results to Table 2.

Table 2: forward active, reverse active and saturation mode

	V <sub>BE</sub>	V <sub>CE</sub>	I <sub>B</sub>	I <sub>C</sub>	β
Forward active mode					
Reverse active mode					
Saturation					

#### The Model for BC238

```
.MODEL BC238 NPN (
+IS =1.8E-14 ISE=5.0E-14 NF =.9955 NE =1.46 BF =400
+BR =35.5 IKF=.14 IKR=.03 ISC=1.72E-13 NC =1.27 NR =1.005 RB =.56 RE =.6
+RC =.25 VAF=80 VAR=12.5 CJE=13E-12 TF =.64E-9 CJC=4E-12 TR =50.72E-9
+VJC=.54 MJC=.33 )
```



### Experiment 1.3.

Setup the common source configuration in Figure 3. Choose  $V_G$  as 10V, and  $V_D$  as 5V. Simulate the circuit by decreasing  $R_2$  value starting from 100k $\Omega$ . Fill in Table 3. Draw the  $I_D-V_{GS}$  curve in Figure 4. Indicate the value of  $V_{th}$  in the  $I_D-V_{GS}$  curve roughly.

Use the MOSFET model at the end of the Experiment 2.5. Set W =160u and L=2u.

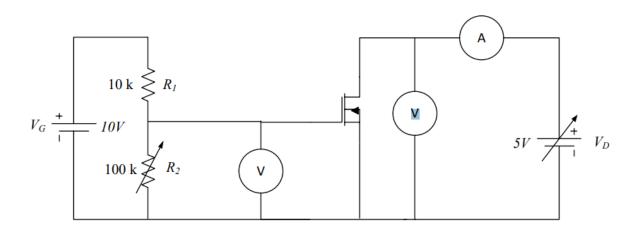


Figure 3:Common source configuration

Table 3: $V_{GS} - I_D$  values of Experiment 1.3

V <sub>GS</sub>	I <sub>D</sub>



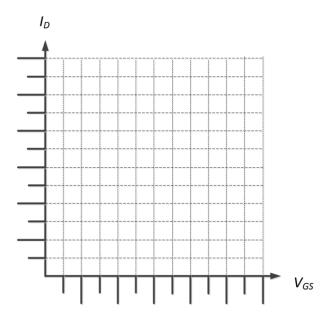


Figure 4:  $I_D - V_{GS}$  curve

### Experiment 1.4.

Choose  $V_G$  as 5V and  $R_2$  as 100k $\Omega$  in Figure 3. Since  $R_2$  is constant,  $V_{GS}$  remains constant. Sweep  $V_D$  value from 0V to 10V and draw  $I_D-V_{DS}$  curve in Figure 5. Indicate different operation regions in  $I_D-V_{GS}$  curve. Fill in Table 4.

Table 4: $V_{DS}-I_{D}$  values of Experiment 1.4

	T
V <sub>DS</sub>	I <sub>D</sub>



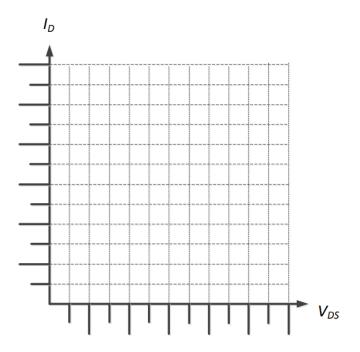


Figure 5:  $I_D - V_{DS}$  curve

```
.MODEL cd4007n NMOS (
 +LEVEL = 49 VERSION = 3.3 TNOM = 23
 +TOX = 1e-07 \text{ XJ} = 1e-06 \text{ NCH} = 2e+16
+VTH0 = 1.14098 K1 = 2.12491 K2 = 0.2
 +U0 = 0.0165798 \text{ UA} = 1e-12 \text{ UB} = 1.31485e-16
+UC = 3.45708e - 09 VSAT = 189307 A0 = 2
 +AGS = 0.481611 B0 = 5.4717e-06 B1 = 0
+KETA = 0.034434 A1 = 0.0462264 A2 = 0.926415
+RDSW = 100 WR = 1 WINT = 1e-06
+LINT = 1e-07 VOFF = -0.0394991 NFACTOR = 0.320755
+CIT = 0 CDSC = 0.00024 CDSCD = 0
 +CDSCB = 0 ETA0 = 0 ETAB = 0
+PCLM = 0.001 PDIBLC1 = 0 PDIBLC2 = 0.0086
+PDIBLCB = 0 DROUT = 0.56 PVAG = 1.03774
+DELTA = 0.0915943 IS = 2.15472e-13 MOBMOD = 1
+CAPMOD = 2 CGDO = 2.3e-10 CGSO = 2.3e-10
+CGBO = 1.065e-10 CJ = 0.000344 PB = 0.95
+MJ = 0.5 CJSW = 2.07e-10 PBSW = 0.95
 +MJSW = 0.5 NOFF = 1 ACDE = 1 +MOIN = 15)
```